

Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)	ATTY. DOCKET NO. 41106-99/YOD (WILA:0008)	SERIAL NO. Unassigned
	APPLICANT Robert R. Krebs	
	FILING DATE Herewith	GROUP Unassigned

U.S. PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
P7N	A1	5,989,668	11/23/1999	Nelson et al.	428	50	
P7N	A2	6,395,373 B2	05/28/2004	Conti et al.	428	138	
P7N	A3	6,495,265	08/28/2000	Krebs et al.	428	460	

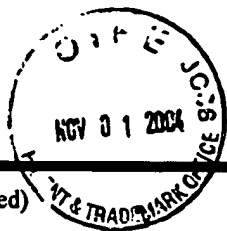
FOREIGN PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION
P7N	B1	WO 03/038777 A1	8 May 2003	PCT	G08B	13/10	YES

OTHER ART (Author, Title, Journal, Volume, Pertinent Pages, & Date)

	C1	
EXAMINER <i>Phylogen</i>		DATE CONSIDERED 06/09/06

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)	ATTY. DOCKET NO. 41106-99/YOD (WILA:0008)	SERIAL NO. 10/797,320
	APPLICANT Robert R. Krebs	
	FILING DATE March 8, 2004	GROUP 1772

U.S. PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
P7N	A1	5,972,156	10/26/1999	Brady et al.	156	280	
P7N	A2	US2002/190132 A1	12/19/2002	Kayanakis.			

FOREIGN PATENT DOCUMENTS

EXAM. INIT.	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION
P7N	B1	WO 02/41237 A1	23 May 2002	PCT	G06K	7/00	YES

OTHER ART (Author, Title, Journal, Volume, Pertinent Pages, & Date)

	C1	
EXAMINER 	DATE CONSIDERED 06/09/06	

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